

**P-Channel Enhancement MOSFET****Features**

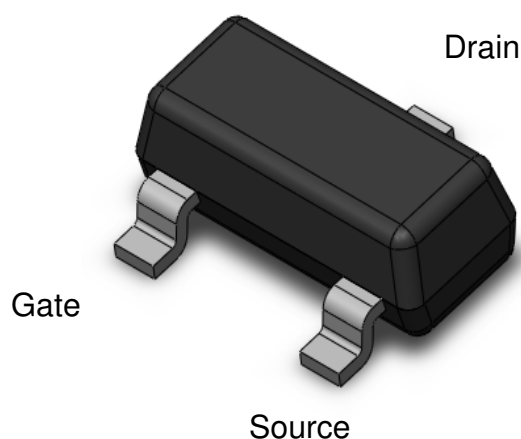
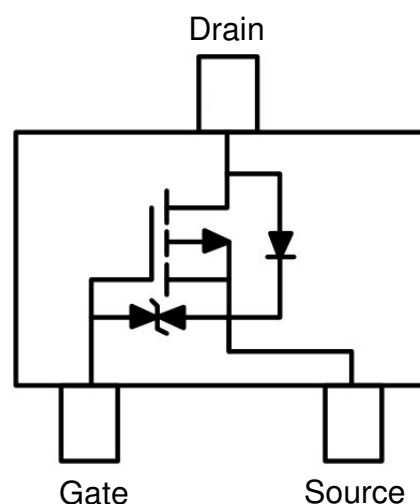
- Drain-Source Breakdown Voltage V_{DS} - 200 V
- Drain-Source On-Resistance
 $R_{DS(ON)}$ 2.3 Ω , at $V_{GS} = -10V$, $I_{DS} = -0.2A$
 $R_{DS(ON)}$ 2.4 Ω , at $V_{GS} = -4.5V$, $I_{DS} = -0.2A$
- Continuous Drain Current at $T_A=25^\circ C$, $I_D = -0.4A$
- Advanced high cell density Trench Technology
- RoHS Compliance & Halogen Free
- ESD Protection

Applications

- Switches
- Power supply circuits
- Motor controls
- Drivers

Description

The CT3331-R3 uses high performance Trench Technology to provide excellent $R_{DS(ON)}$ and low gate charge which is suitable for most of the synchronous buck converter applications .

Package Outline**Schematic**

**P-Channel Enhancement MOSFET****Absolute Maximum Rating at 25°C**

Symbol	Parameters	Ratings	Units	Notes
V_{DS}	Drain-Source Voltage	-200	V	
V_{GS}	Gate-Source Voltage	± 20	V	
I_D	Continuous Drain Current @ $T_A=25^\circ\text{C}$	-0.4	A	1
I_{DM}	Pulsed Drain Current	-1.6	A	1
P_D	Total Power Dissipation @ $T_A=25^\circ\text{C}$	1.1	W	2
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$	
T_J	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$	

Thermal Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
$R_{\theta JA}$	Thermal Resistance Junction-Ambient ($t=10\text{s}$)		-	121	-	$^\circ\text{C/W}$	1,4



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Electrical Characteristics $T_A = 25^\circ\text{C}$ (unless otherwise specified)

Static Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
B _{VDS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D = -250μA	-200	-	-	V	
I _{DSS}	Drain-Source Leakage Current	V _{DS} = -200V, V _{GS} = 0V	-	-	-1	μA	
I _{GSS}	Gate-Source Leakage Current	V _{GS} = ±16V, V _{DS} = 0V	-	-	±10	μA	

On Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
R _{DS(ON)}	Drain-Source On-Resistance	V _{GS} = -10V, I _D = -200mA	-	2.3	4		3
		V _{GS} = -4.5V, I _D = -200mA	-	2.4	4.5		
V _{GS(TH)}	Gate-Source Threshold Voltage	V _{GS} = V _{DS} , I _D = -250μA	-1.2	-	-2.6	V	3

Dynamic Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
C _{ISS}	Input Capacitance	V _{DS} = -20V , V _{GS} = 0V, f=1MHz	-	350	-	pF	
C _{OSS}	Output Capacitance		-	30	-		
C _{RSS}	Reverse Transfer Capacitance		-	12	-		

Switching Characteristics

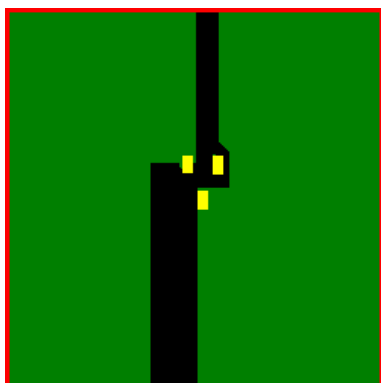
Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
T _{D(ON)}	Turn-On Delay Time	V _{DS} = -100V , V _{GS} = -4.5V, R _G = 4.7Ω, I _D = -2.8A	-	10	-	ns	
T _R	Rise Time		-	4	-		
T _{D(OFF)}	Turn-Off Delay Time		-	43	-		
T _F	Fall Time		-	42	-		
Q _G	Total Gate Charge	V _{DS} = -100V , V _{GS} = -10V, I _D = -400mA	-	7.0	-	nC	
Q _{GS}	Gate-Source Charge		-	1.0	-		
Q _{GD}	Gate-Drain (Miller) Charge		-	0.8	-		

**Drain-Source Diode Characteristics**

<i>Symbol</i>	<i>Parameters</i>	<i>Test Conditions</i>	<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Units</i>	<i>Notes</i>
V _{SD}	Body Diode Forward Voltage	V _{GS} = 0V, I _{SD} = -1.0A		-0.78	-1.2	V	
I _{SD}	Body Diode Continuous Current				-2.8	A	1

Note:

1. The power dissipation is limited by 150°C junction temperature.
2. Device mounted on a glass-epoxy board



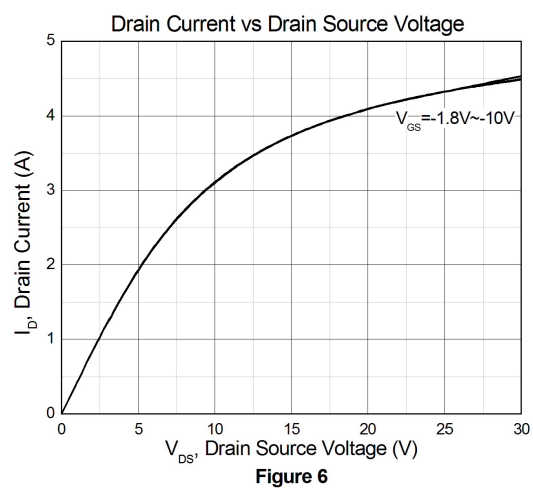
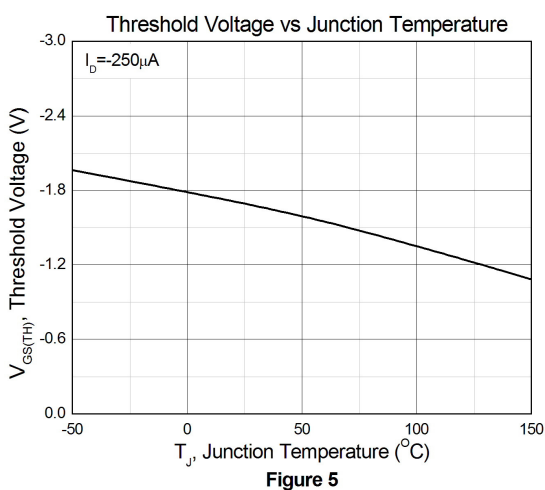
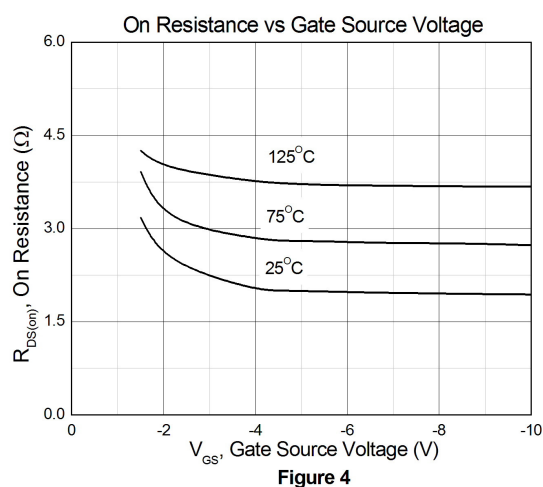
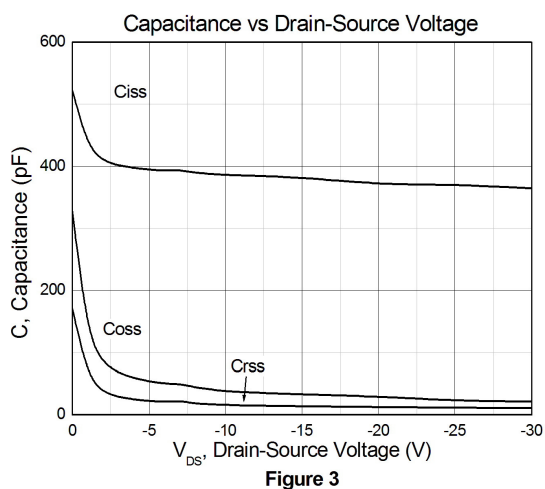
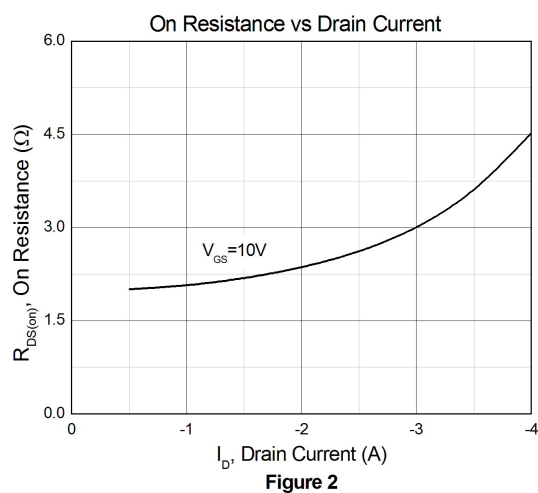
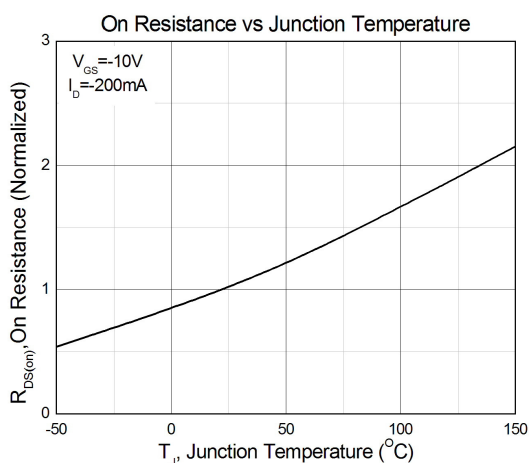
FR-4
25.4 × 25.4 mm .
2 Oz Copper

Actual Size

3. The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
4. Thermal Resistance follow JESD51-3.



Typical Characteristic Curves





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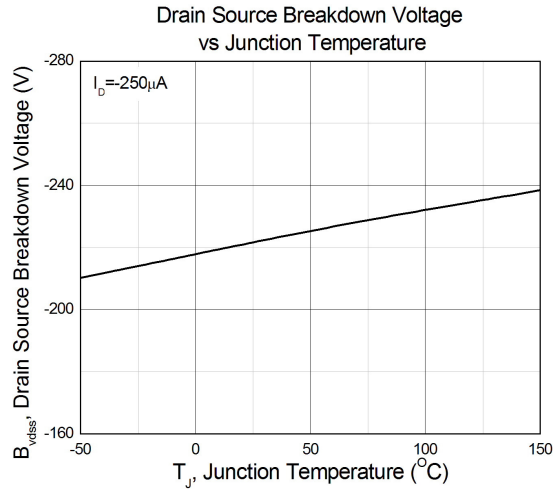


Figure 7

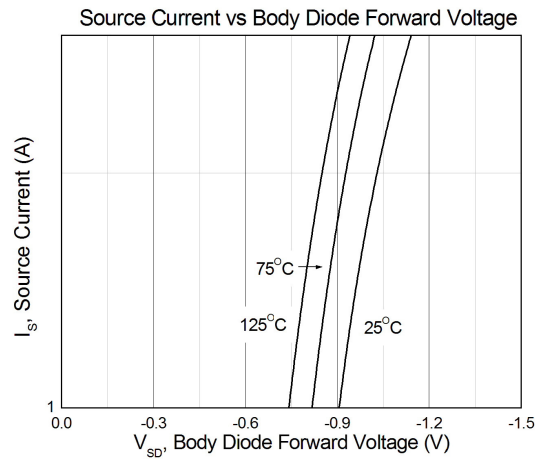


Figure 8

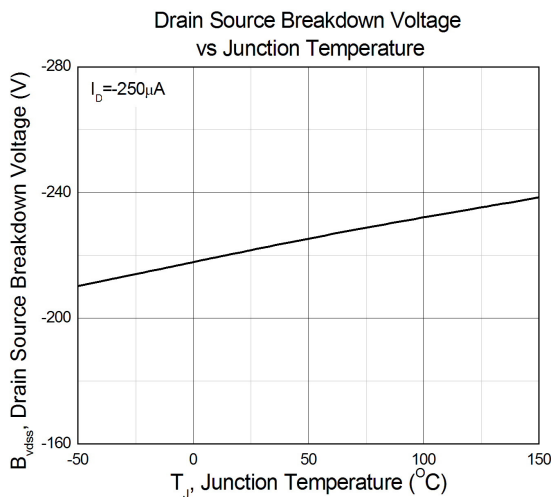


Figure 9

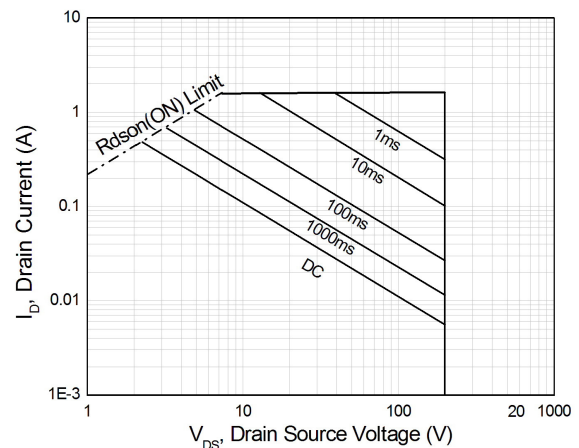


Figure 10

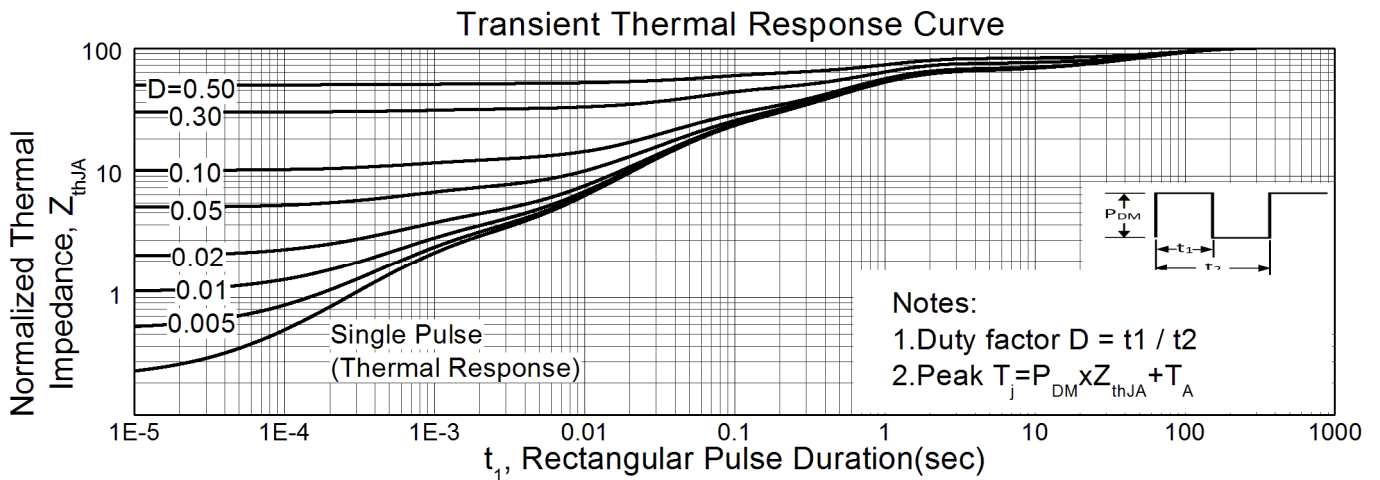


Figure 11



Test Circuits & Waveforms

Figure 12: Gate Charge Test Circuit

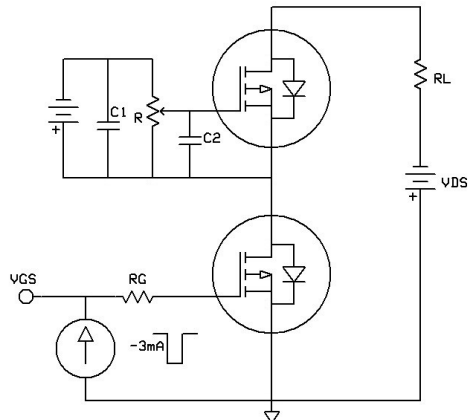


Figure 13: Gate Charge Waveform

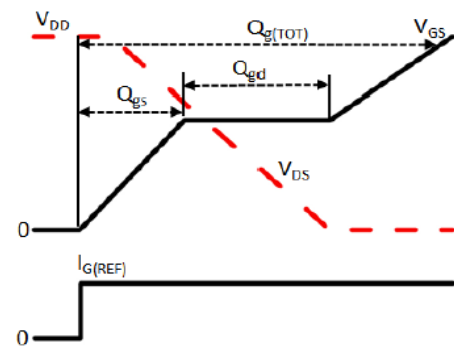


Figure 14: Switching Time Test Circuit

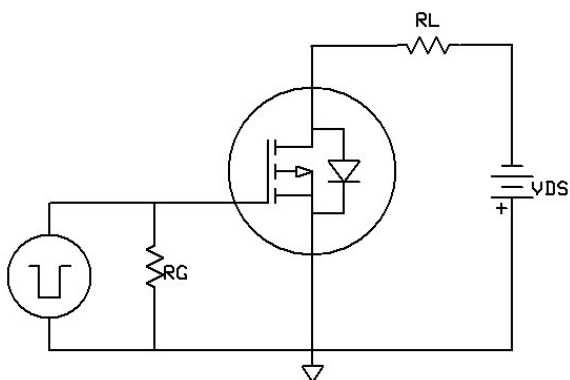
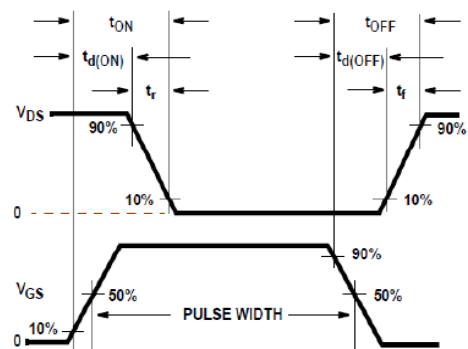
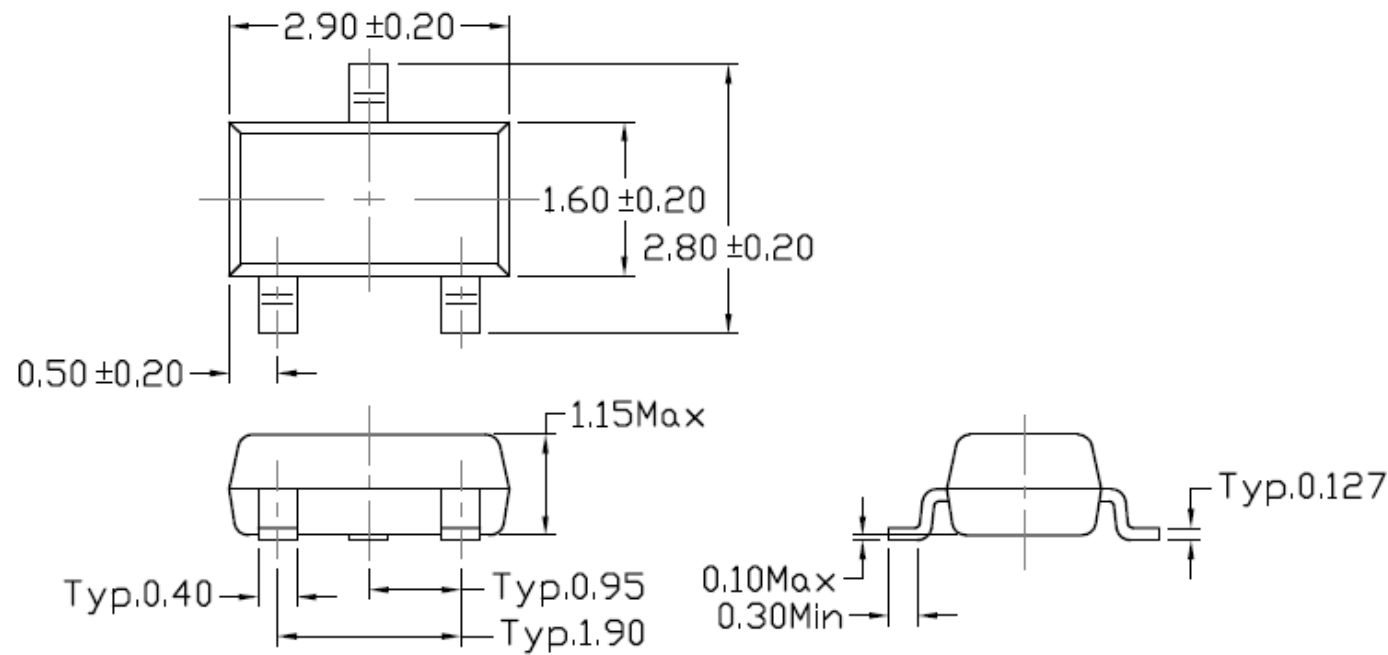


Figure 15: Switching Time Waveform



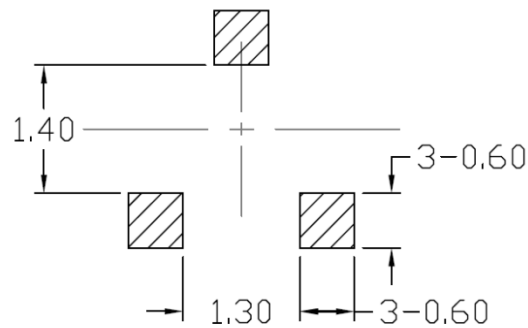


Package Dimension (SC-59)



Note: Dimensions in mm

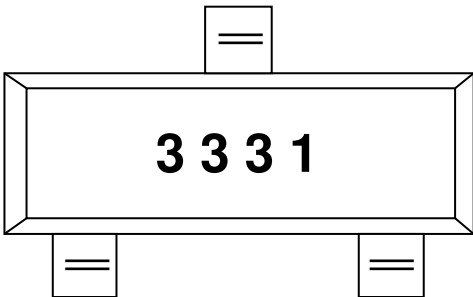
Recommended pad layout for surface mount leadform



Note: Dimensions in mm



Marking Information



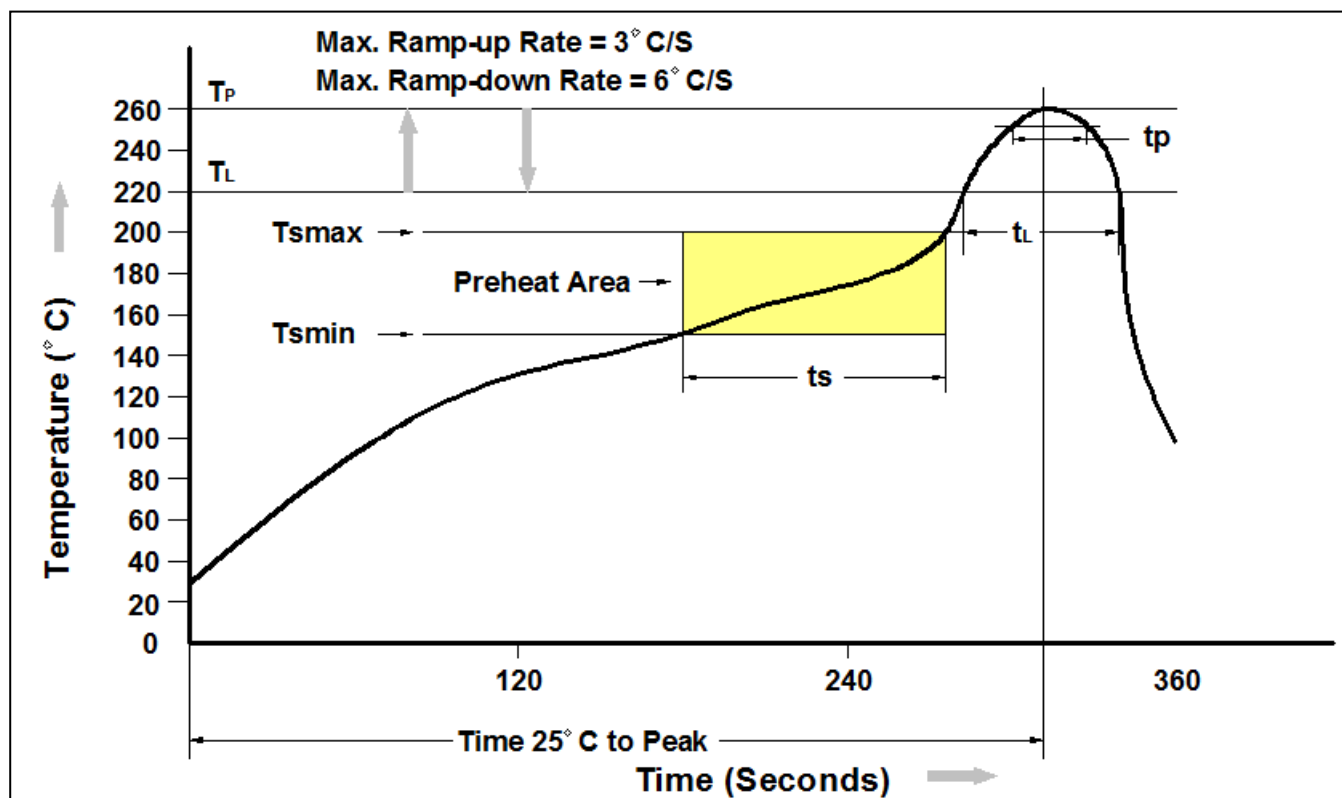
3331 : Device Number

Ordering Information

Part Number	Description	Quantity
CT3331-R3	SC-59 Reel	3000 pcs



Reflow Profile



Profile Feature	Pb-Free Assembly Profile
Temperature Min. (Tsmin)	150°C
Temperature Max. (Tsmax)	200°C
Time (ts) from (Tsmin to Tsmax)	60-120 seconds
Ramp-up Rate (t _L to t _P)	3°C/second max.
Liquidous Temperature (T _L)	217°C
Time (t _L) Maintained Above (T _L)	60 – 150 seconds
Peak Body Package Temperature	260°C +0°C / -5°C
Time (t _P) within 5°C of 260°C	30 seconds
Ramp-down Rate (T _P to T _L)	6°C/second max
Time 25°C to Peak Temperature	8 minutes max.



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